## Notice of References Cited Application/Control No. 10/787,247 Examiner Sheldon J. Richter Applicant(s)/Patent Under Reexamination BAYERL, JOHANN Art Unit Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-4,476,682 A	10-1984 ´	McInerney, Charles E.	60/602
	В	US-6,178,748 B1	01-2001	Oleksiewicz, Radek A.	60/602
	С	US-6,276,139 B1	08-2001	Moraal et al.	60/611
	D	US-6,295,816 B1	10-2001	Gallagher et al.	60/611
	Ε	US-6,457,312 B2	10-2002	Fahringer et al.	60/611
	F	US-6,722,128 B1	04-2004	Adrian, John	60/611
	G	US-6,898,934 B1	05-2005	Bayer et al.	60/611 .
	Н	US-			
	ı	US-			
	J	US-			
	к	US-			
	L	US-			
	М	US-			

## **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)				
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A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.